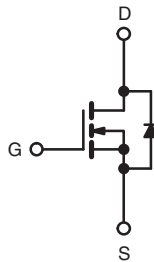
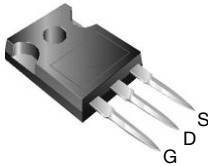


## Power MOSFET

PRODUCT SUMMARY	
$V_{DS}$ at $T_J$ max. (V)	650
$R_{DS(on)}$ ( $\Omega$ )	$V_{GS} = 10\text{ V}$ 0.190
$Q_g$ (Max.) (nC)	98
$Q_{gs}$ (nC)	17
$Q_{gd}$ (nC)	25
Configuration	Single

**TO-247AC**


N-Channel MOSFET

### FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- High  $E_{AR}$  Capability
- Lower Figure-of-Merit  $R_{on} \times Q_g$
- 100 % Avalanche Tested
- High Peak Current Capability
- $dV/dt$  Ruggedness
- Effective  $C_{oss}$  Specified
- Improved Transconductance
- Improved  $t_{rr}/Q_{rr}$
- Improved Gate Charge
- High Power Dissipation Capability
- Compliant to RoHS Directive 2002/95/EC



**RoHS\***  
COMPLIANT  
HALOGEN  
**FREE**  
Available

ORDERING INFORMATION	
Package	TO-247AC
Lead (Pb)-free	SiHG22N60S-E3
Lead (Pb)-free and Halogen-free	SiHG22N60S-GE3


ABSOLUTE MAXIMUM RATINGS ( $T_C = 25\text{ }^\circ\text{C}$ , unless otherwise noted)					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			$V_{DS}$	600	V
Gate-Source Voltage			$V_{GS}$	$\pm 20$	
Continuous Drain Current <sup>a</sup>	$V_{GS}$ at 10 V	$T_C = 25\text{ }^\circ\text{C}$	$I_D$	22	A
		$T_C = 100\text{ }^\circ\text{C}$		13	
Pulsed Drain Current <sup>b</sup>			$I_{DM}$	65	
Linear Derating Factor	TO-247			2	W/ $^\circ\text{C}$
Single Pulse Avalanche Energy <sup>c</sup>			$E_{AS}$	690	mJ
Repetitive Avalanche Energy <sup>b</sup>			$E_{AR}$	25	
Maximum Power Dissipation	TO-247		$P_D$	250	W
Peak Diode Recovery $dV/dt$ <sup>d</sup>			$dV/dt$	7.3	V/ns
Operating Junction and Storage Temperature Range			$T_J, T_{stg}$	- 55 to + 150	$^\circ\text{C}$
Soldering Recommendations (Peak Temperature) <sup>e</sup>	for 10 s			300	

#### Notes

- Limited by maximum junction temperature.
- Repetitive rating; pulse width limited by maximum junction temperature.
- $V_{DD} = 50\text{ V}$ , starting  $T_J = 25\text{ }^\circ\text{C}$ ,  $L = 28.2\text{ mH}$ ,  $R_g = 25\text{ }\Omega$ ,  $I_{AS} = 7\text{ A}$ .
- $I_{SD} \leq 22\text{ A}$ ,  $dI/dt \leq 340\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150\text{ }^\circ\text{C}$ .
- 1.6 mm from case.

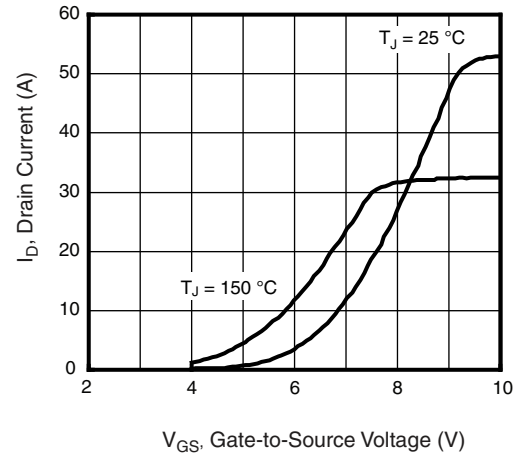
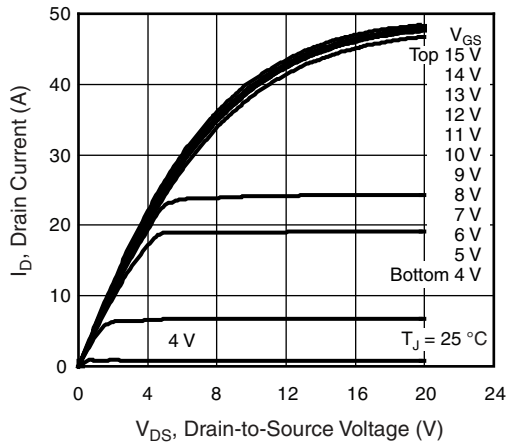
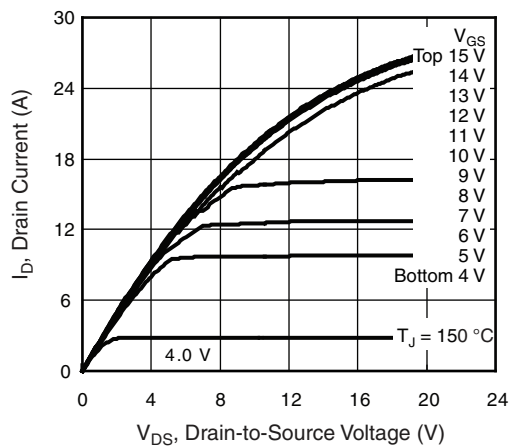
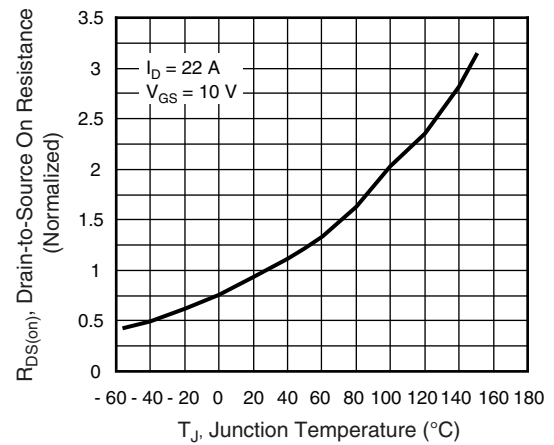
\* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	TO-247	$R_{thJA}$	-	62	°C/W
Maximum Junction-to-Case (Drain)	TO-247	$R_{thJC}$	-	0.5	

SPECIFICATIONS ( $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0\text{ V}, I_D = 1\text{ mA}$		600	-	-	V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to $25\text{ }^\circ\text{C}$ , $I_D = 1\text{ mA}$		-	0.70	-	V/°C
Gate-Source Threshold Voltage (N)	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$		2.0	-	4.0	V
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20\text{ V}$		-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}$		-	-	1	$\mu\text{A}$
		$V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}, T_J = 150\text{ }^\circ\text{C}$		-	-	100	
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}$	$I_D = 22\text{ A}$	-	0.160	0.190	$\Omega$
Forward Transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = 50\text{ V}, I_D = 13\text{ A}$		-	9.4	-	S
<b>Dynamic</b>							
Input Capacitance	$C_{iss}$	$V_{GS} = 0\text{ V},$ $V_{DS} = 25\text{ V},$ $f = 1.0\text{ MHz}$		-	2810	-	pF
Output Capacitance	$C_{oss}$			-	1480	-	
Reverse Transfer Capacitance	$C_{rss}$			-	33	-	
Effective Output Capacitance (Time Related)	$C_{oss\text{ eff. (TR)}}^a$	$V_{GS} = 0\text{ V}$	$V_{DS} = 0\text{ V to } 480\text{ V}$	-	155	-	
Total Gate Charge	$Q_g$	$V_{GS} = 10\text{ V}$	$I_D = 22\text{ A}, V_{DS} = 480\text{ V}$	-	75	-	nC
Gate-Source Charge	$Q_{gs}$			-	17	-	
Gate-Drain Charge	$Q_{gd}$			-	25	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 380\text{ V}, I_D = 22\text{ A},$ $R_g = 9.1\text{ }\Omega, V_{GS} = 10\text{ V}$		-	24	-	ns
Rise Time	$t_r$			-	68	-	
Turn-Off Delay Time	$t_{d(off)}$			-	77	-	
Fall Time	$t_f$			-	59	-	
Gate Input Resistance	$R_g$	$f = 1\text{ MHz}, \text{ open drain}$		-	0.65	-	$\Omega$
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode 		-	-	22	A
Pulsed Diode Forward Current	$I_{SM}$			-	-	88	
Diode Forward Voltage	$V_{SD}$	$T_J = 25\text{ }^\circ\text{C}, I_S = 22\text{ A}, V_{GS} = 0\text{ V}$		-	-	1.2	V
Reverse Recovery Time	$t_{rr}$	$T_J = 25\text{ }^\circ\text{C}, I_F = I_S,$ $di/dt = 100\text{ A}/\mu\text{s}, V_R = 25\text{ V}$		-	462	-	ns
Reverse Recovery Charge	$Q_{rr}$			-	8.3	-	$\mu\text{C}$
Reverse Recovery Current	$I_{RRM}$			-	30	-	A

**Note**

a.  $C_{oss\text{ eff. (TR)}}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

**Fig. 1 - Typical Output Characteristics,  $T_J = 25\text{ }^\circ\text{C}$** 
**Fig. 3 - Typical Transfer Characteristics**

**Fig. 2 - Typical Output Characteristics,  $T_J = 150\text{ }^\circ\text{C}$** 

**Fig. 4 - Normalized On-Resistance vs. Temperature**

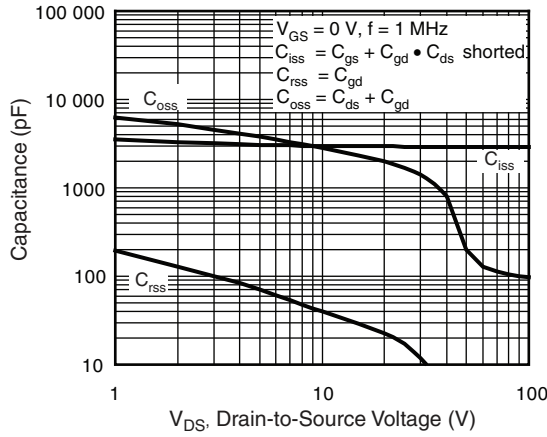


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

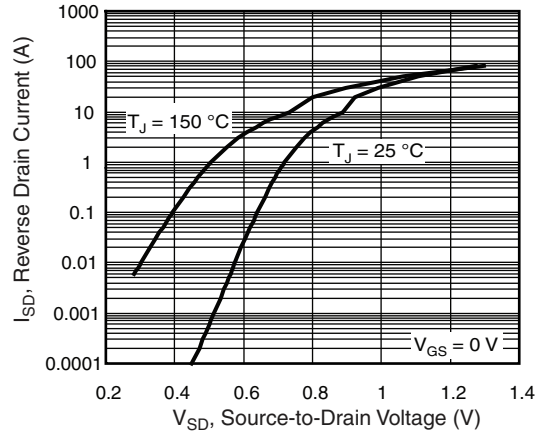


Fig. 7 - Typical Source-Drain Diode Forward Voltage

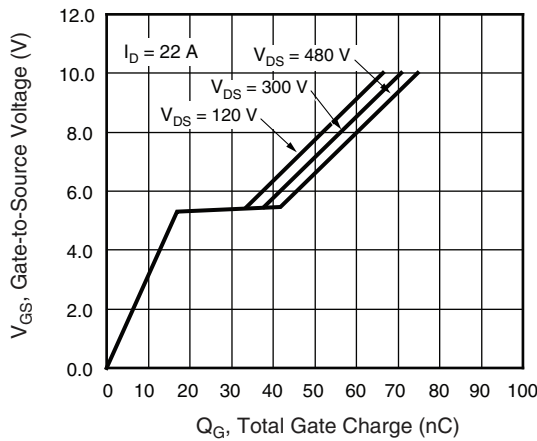


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

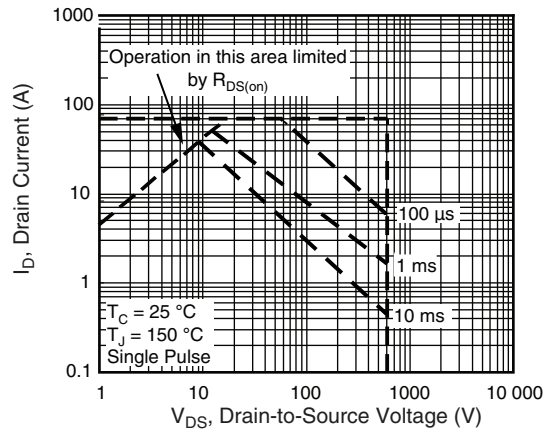
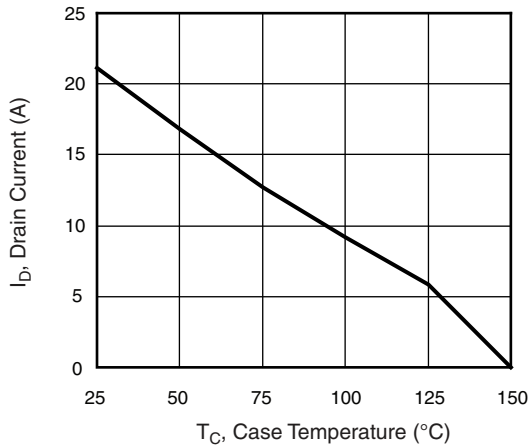
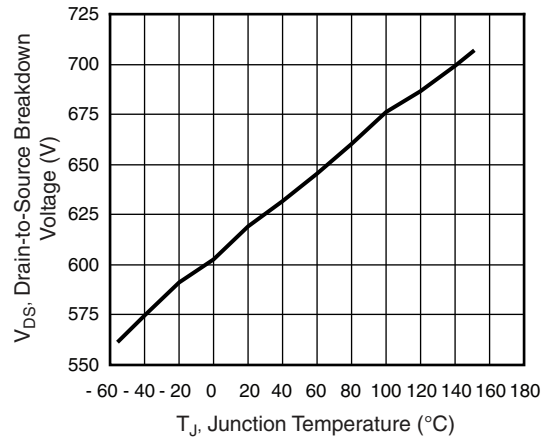


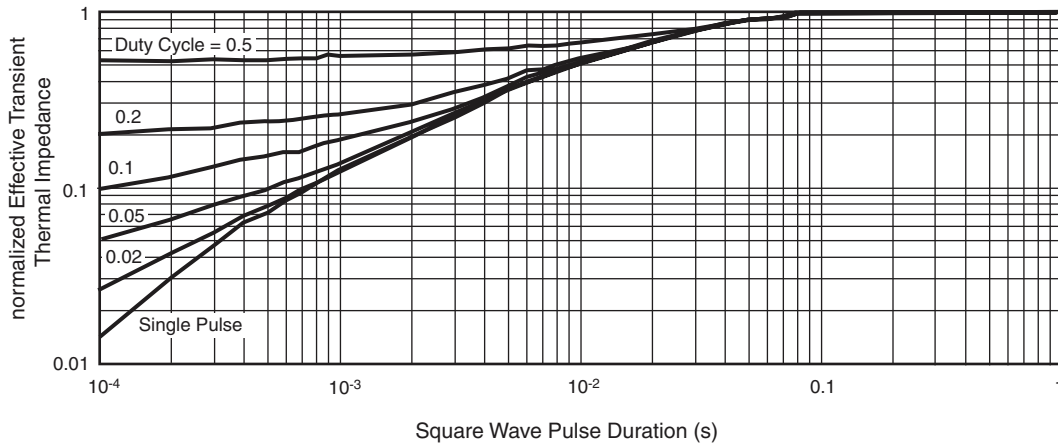
Fig. 8 - Maximum Safe Operating Area



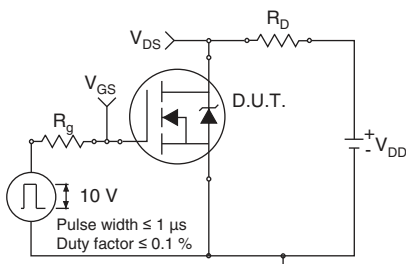
**Fig. 9 - Maximum Drain Current vs. Case Temperature**



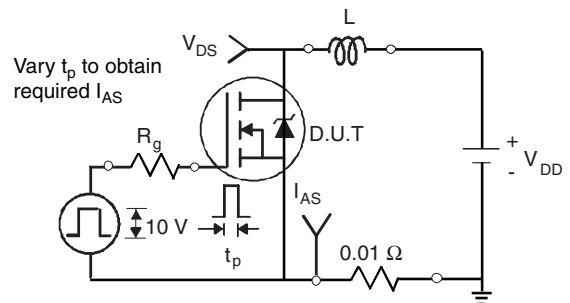
**Fig. 10 - Drain-to-Source Breakdown Voltage**



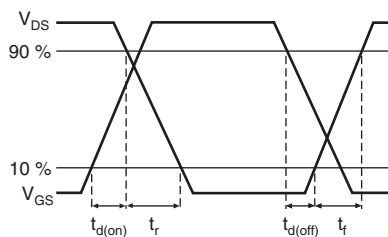
**Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case**



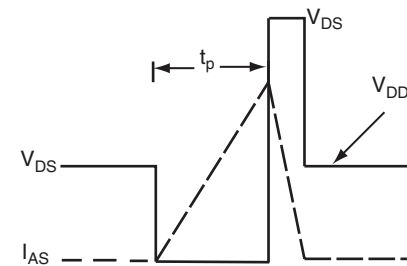
**Fig. 11a - Switching Time Test Circuit**



**Fig. 12a - Unclamped Inductive Test Circuit**



**Fig. 11b - Switching Time Waveforms**



**Fig. 12b - Unclamped Inductive Waveforms**

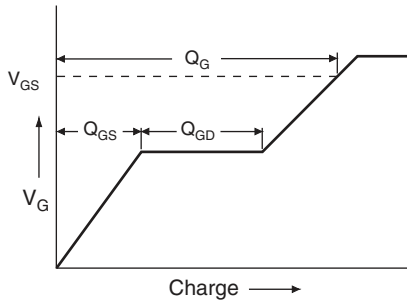


Fig. 13a - Basic Gate Charge Waveform

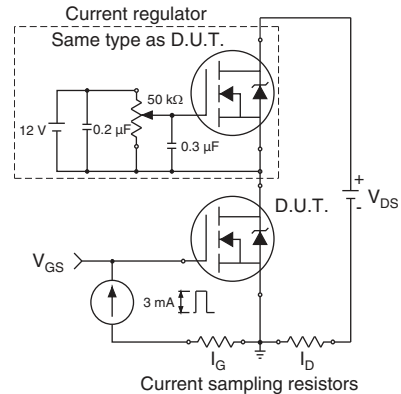
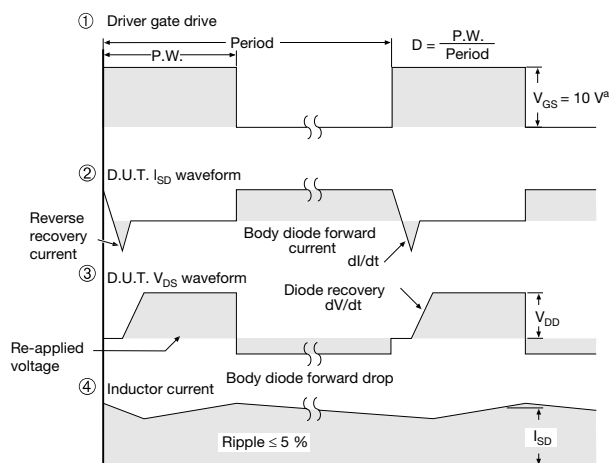
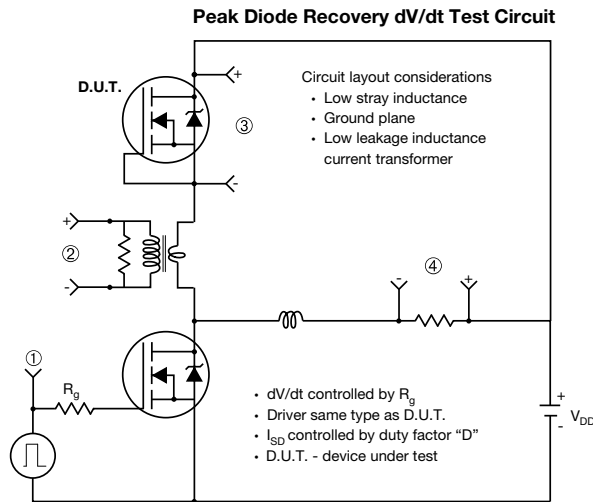


Fig. 13b - Gate Charge Test Circuit



Note  
a.  $V_{GS} = 5\text{ V}$  for logic level devices

Fig. 14 - For N-Channel

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